

#### **Features**

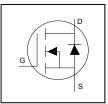
- Advanced Process Technology
- Ultra Low On-Resistance
- Enhanced dV/dT and dI/dT capability
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

### Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



HEXFET® Power MOSFET



V <sub>DSS</sub>	100V
R <sub>DS(on) typ.</sub>	$3.7$ m $\Omega$
max	4.5m $Ω$
I <sub>D (Silicon Limited)</sub>	180A①
I <sub>D</sub> (Package Limited)	120A



G	D	S
Gate	Drain	Source

Base next number	Dookogo Tymo	Standard Pack		Orderable Dout Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFP4110	TO-247AC	Tube	25	AUIRFP4110

#### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	<b>180</b> ①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	130①	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	120	_ A
I <sub>DM</sub>	Pulsed Drain Current ②	670	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	370	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ③	190	mJ
I <sub>AR</sub>	Avalanche Current ②	108	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	37	mJ
dv/dt	Peak Diode Recovery 4	5.3	V/ns
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	7
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

## **Thermal Resistance**

	D	T	N4	1114-
	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.402	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.24		°C/W
$R_{\theta JA}$	Junction-to-Ambient		40	

HEXFET® is a registered trademark of Infineon.

<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.108		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.7	4.5	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ⑤
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Trans conductance	160			S	V <sub>DS</sub> = 50V, I <sub>D</sub> = 75A
	Dunin to Course Lookens Courset			20		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	ΠA	V <sub>GS</sub> = -20V
$R_G$	Gate Resistance		1.3		Ω	

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

$Q_g$	Total Gate Charge	 150	210		I <sub>D</sub> = 75A
$Q_{gs}$	Gate-to-Source Charge	 35		nC	V <sub>DS</sub> = 50V
$Q_{gd}$	Gate-to-Drain Charge	 43			V <sub>GS</sub> = 10V⑤
$t_{d(on)}$	Turn-On Delay Time	 25			V <sub>DD</sub> = 65V
t <sub>r</sub>	Rise Time	 67			I <sub>D</sub> = 75A
$t_{d(off)}$	Turn-Off Delay Time	 78		ns	$R_G = 2.6\Omega$
t <sub>f</sub>	Fall Time	 88			V <sub>GS</sub> = 10V⑤
C <sub>iss</sub>	Input Capacitance	 9620			$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	 670			V <sub>DS</sub> = 50V
$C_{rss}$	Reverse Transfer Capacitance	 250		pF	f = 1.0MHz
C <sub>oss eff.(ER)</sub>	Effective Output Capacitance (Energy Related)	 820		•	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 80V⑦
Coss eff.(TR)	Output Capacitance (Time Related)	 950			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$

#### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			180①		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ②			670		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C, I_S = 75A, V_{GS} = 0V $ §
4	Reverse Recovery Time		50	75	200	$T_{J} = 25^{\circ}C$ $V_{DD} = 85V$
t <sub>rr</sub>	Reverse Recovery Time		60	90	ns	$T_J = 125^{\circ}C$ $I_F = 75A$ ,
0	Daviera Dasaver Charge		94	140	5	$T_J = 25^{\circ}C$ di/dt = 100A/µs ©
$Q_{rr}$	Reverse Recovery Charge		140	210	nC	<u>T<sub>J</sub> = 125°C</u>
I <sub>RRM</sub>	Reverse Recovery Current		3.5		Α	$T_J = 25^{\circ}C$

#### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 120A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by  $T_{Jmax}$ , starting  $T_J = 25^{\circ}C$ , L = 0.033mH,  $R_G = 25\Omega$ ,  $I_{AS} = 108$ A,  $V_{GS} = 10$ V. Part not recommended for use above this value.
- © Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- © Coss eff. (ER) is a fixed capacitance that gives the same energy as Coss while VDS is rising from 0 to 80% VDSS.
- $^{\circ}$  R<sub>0</sub> is measured at TJ approximately 90°C.



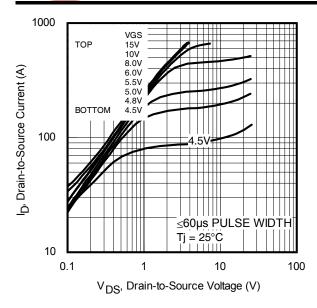


Fig 1. Typical Output Characteristics

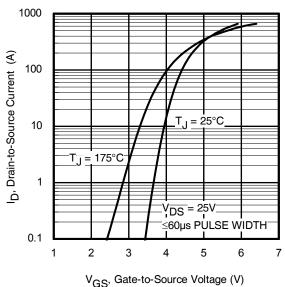


Fig 3. Typical Transfer Characteristics

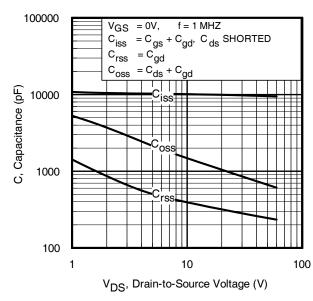


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

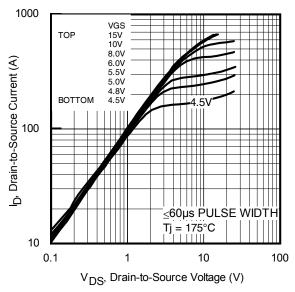


Fig 2. Typical Output Characteristics

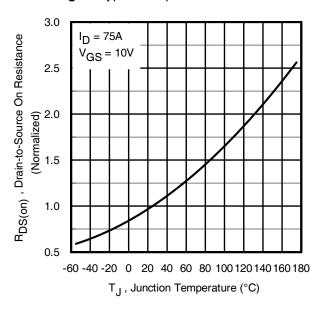


Fig 4. Normalized On-Resistance vs. Temperature

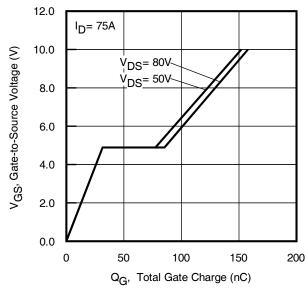


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



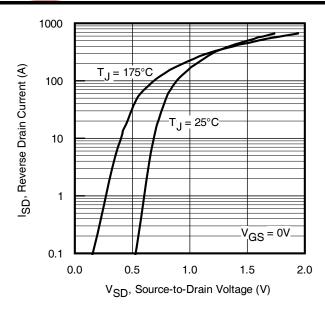


Fig 7. Typical Source-Drain Diode Forward Voltage

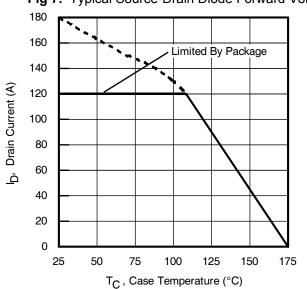


Fig 9. Maximum Drain Current vs. Case Temperature

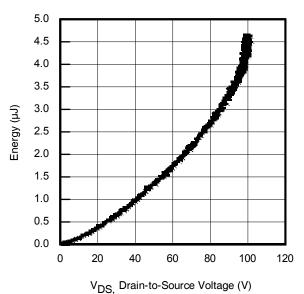


Fig 11. Typical Coss Stored Energy

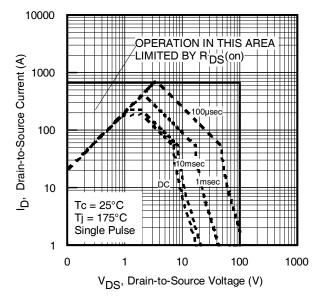


Fig 8. Maximum Safe Operating Area

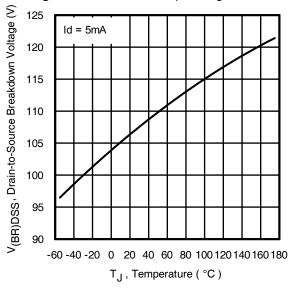


Fig 10. Drain-to-Source Breakdown Voltage

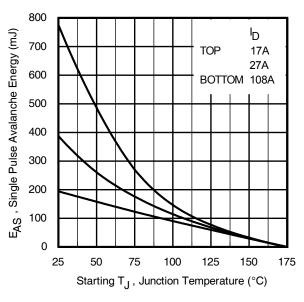


Fig 12. Threshold Voltage vs. Temperature

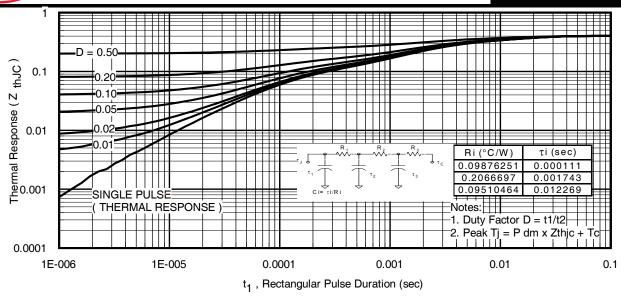


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

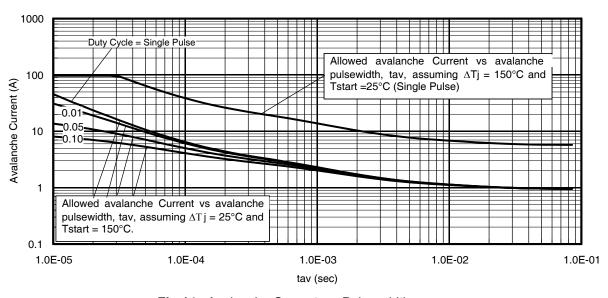


Fig 14. Avalanche Current vs. Pulse width

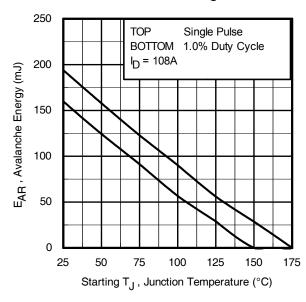


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of Tjmax. This is validated for every part type.

- Safe operation in Avalanche is allowed as long asTjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a,22b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7. ∆T = Allowable rise in junction temperature, not exceed T<sub>jmax</sub> (assumed as 25°C in figure 14 , 15).
  tav = Average time in avalanche.
  D = Duty cycle in avalanche = tav ·f
  ZthJC (D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \, (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [\; 1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \, (AR)} &= PD \; _{(ave)} \cdot t_{av} \end{split}$$



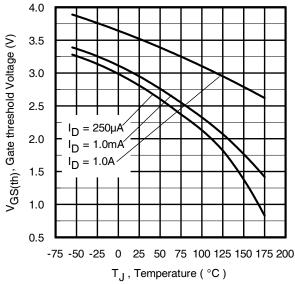


Fig 16. Threshold Voltage vs. Temperature

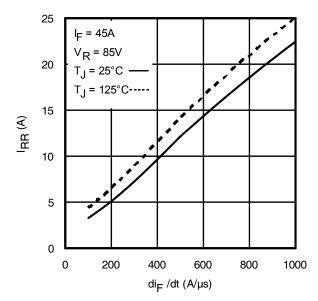
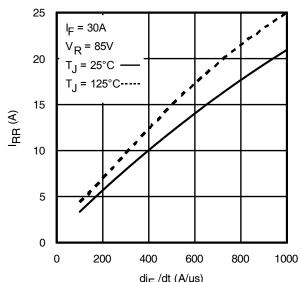


Fig 18. Typical Recovery Current vs. dif/dt



di<sub>F</sub> /dt (A/μs) **Fig 17.** Typical Recovery Current vs. dif/dt

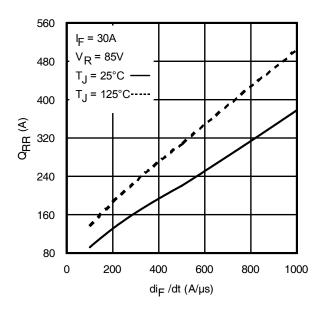


Fig 19. Typical Stored Charge vs. dif/dt

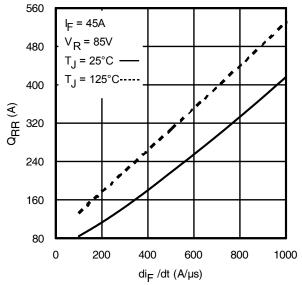


Fig 20. Typical Stored Charge vs. dif/dt



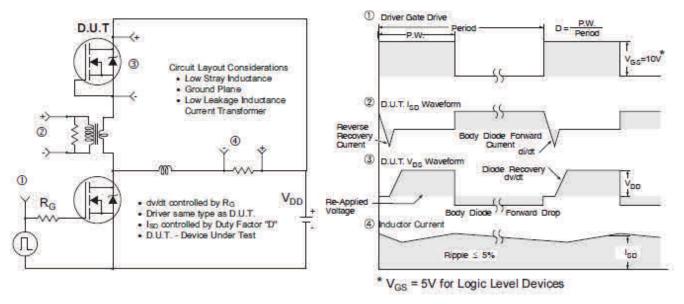


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

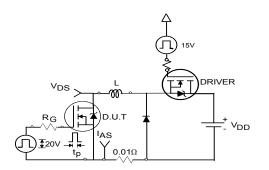


Fig 22a. Unclamped Inductive Test Circuit

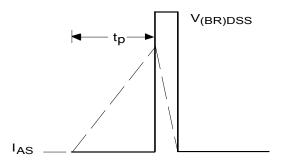


Fig 22b. Unclamped Inductive Waveforms

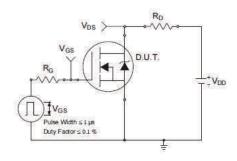


Fig 23a. Switching Time Test Circuit

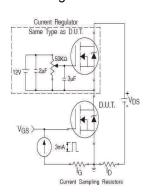


Fig 24a. Gate Charge Test Circuit

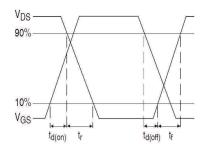


Fig 23b. Switching Time Waveforms

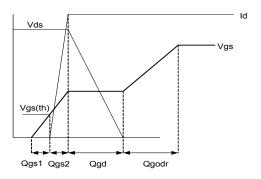
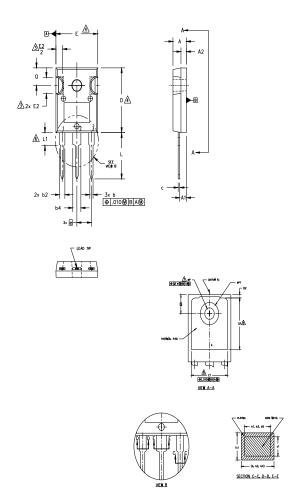


Fig 24b. Gate Charge Waveform



# TO-247AC Package Outline

Dimensions are shown in millimeters (inches)



#### NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
- DIMENSIONS ARE SHOWN IN INCHES.
- CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 ' TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

		DIMEN	imensions			
SYMBOL	INC	HES	MILLIM	ETERS	1	
	MIN.	MAX.	MIN.	MAX.	NOTES	
A	.183	.209	4.65	5.31		
A1	.087	.102	2.21	2.59		
A2	.059	.098	1.50	2.49		
b	.039	.055	0.99	1.40		
b1	.039	.053	0.99	1.35		LEAD ASSIGN
b2	.065	.094	1.65	2.39		
b3	.065	.092	1.65	2.34		HEXFET
b4	.102	.135	2.59	3.43		112/11/21
b5	.102	.133	2.59	3.38		1 GA
С	.015	.035	0.38	0.89		2 DR
c1	.015	.033	0.38	0.84		3 SO
D	.776	.815	19.71	20.70	4	4 DR
D1	.515	-	13.08	-	5	
D2	.020	.053	0.51	1.35		
E	.602	.625	15.29	15.87	4	IGBTs, CoP.
E1	.530	-	13.46	-		1 GA
E2	.178	.216	4.52	5.49		2 COI
e	.215	BSC	5.46	BSC	]	3 EM
Øk	.0	10	0.	25		4 COI
L	.559	.634	14.20	16.10		
L1	.146	.169	3.71	4,29		
ØΡ	.140	.144	3.56	3.66		DIODES
øP1	-	.291	-	7.39		
Q	.209	.224	5.31	5,69		1 ANO
S	.217	BSC	5.51	BSC		2 CA
1	i e				1	3 – ΔN

### MENTS

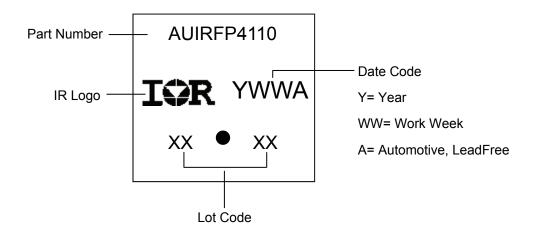
- OURCE

### <u>PACK</u>

- OLLECTOR
- MITTER OLLECTOR

- NODE/OPEN
- 3.- ANODE

# TO-247AC Part Marking Information



TO-247AC package is not recommended for Surface Mount Application.



#### **Qualification Information**

	IIIIOIIIIatioii							
		Automotive						
			(per AEC-Q101)					
Qualification	Level		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Moisture Sen	sitivity Level	TO-247AC N/A						
	Machine Model	Class M4 (+/- 800) <sup>†</sup>						
		AEC-Q101-002						
ECD	Human Body Model		Class H3A (+/- 6000V) <sup>†</sup>					
ESD		AEC-Q101-001						
	Charged Device Model	Class C5 (+/- 2000) <sup>†</sup>				Class C5 (+/- 2000) <sup>†</sup>		
			AEC-Q101-005					
RoHS Compl	iant	Yes						

<sup>†</sup> Highest passing voltage.

## **Revision History**

Date	Comments				
9/15/2017	Updated datasheet with corporate template				
9/13/2017	Corrected typo error on part marking on page 8.				

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